

SHEET 1 OF 2

Form PTO 1449		U.S. DEPARTMENT		ATTY DOCKET NO.		SERIAL NO.						
(Modified)		PATENT AND TRAD	EMARK OFFICE	245600US0	10/714,853							
				APPLICANT								
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Hideyuki OTSUKA, et al.								
				FILING DATE		GROUP						
		<u> </u>		November 18, 2003								
U.S. PATENT DOCUMENTS												
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE						
16	AA	2001/0004667 A1	06/21/2001	M. OKUBO, et al.								
10	AB	5,529,872	06/25/1996	K. GRYCHTOL, et al.								
16	AC	5,204,453	04/20/1993	B. CHAMBON, et al.								
10	AD	2002/0156161 A1	10/24/2002	R. KOSHIDA, et al.								
FOREIGN PATENT DOCUMENTS												
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES N		NO NO				
10-	AE	WO 03/098617	11/27/2003	WIPO			<u> </u>	110				
10	AF	2003-231843	08/19/2003	JAPAN		·	- 					
10	AG	2004-2618	01/08/2004	JAPAN								
10	AH	2003-15364	01/17/2003	JAPAN								
16	Al	2002-82481	03/22/2002	JAPAN								
16	AJ	2002-82480	03/22/2002	JAPAN								
16	AL	2001-356526	12/26/2001	JAPAN								
10	AL	2001-194830	07/19/2001	JAPAN								
10	AM	11-133670	05/21/1999	JAPAN								
14	AN	10-48875	02/20/1998	JAPAN								
16	AO	0 977 093	02/02/2000	EUROPE								
10	AP	WO 94/03841	02/17/1994	WIPO (with English Abstract)				х				
1/4	AQ	60-106859	06/12/1985	JAPAN								
16	AR	60-107655	06/13/1985	JAPAN				··				
16	AS	2-305832	12/19/1990	JAPAN (with English Abstract)	-			х				
16	AT	43-17955	07/30/1968	JAPAN				х				
10	AU	43-27596	11/27/1968	JAPAN				X				
16	AV	57-167033	10/14/1982	JAPAN (with English Abstract)				x				
10	AW	8-500912	01/30/1996	JAPAN (with English Abstract and corr. US 5,529,872)				×				
10	AX	61-155464	07/15/1986	JAPAN (with English Abstract)				X				
Il	AY	11-20317	01/26/1999	JAPAN (with English Abstract)		· · · · · ·		×				
16	ΑZ	5-192638	08/03/1993	JAPAN (with English Abstract)				X				
					Addi	tional Refe	rences sheet(s) attached				
Examiner J Goodrow					Date Considered 9/03							
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant												

SHEET 2 OF 2

Form PTO 1449	U.S. DE FRANCE OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO. 10/714,853			
(Modified)				245600US0					
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT	···	<u> </u>			
				Hideyuki OTSUKA, et al.					
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION			
16	l AA	7-32535	02/03/1995	JAPAN (with English Abstract)		YES	NO		
16	AB	7-32540	02/03/1995	JAPAN (with English Abstract)			X		
16	AC	7-32539	02/03/1995	JAPAN (with English Abstract)			X		
10	AD	7-227570	08/29/1995	JAPAN (with English Abstract)			X		
11-	AE		02/03/1995	JAPAN (with English Abstract)			X		
700	AF	62-225563	10/03/1987	JAPAN (with English Abstract and			X		
16	 	02-22300	10/03/190/	corr. US 5,204,453)			×		
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		OTHER RE	FERENCES (Including Author, Title, Date, Pertinen	it Pages, et	c.)	-		
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	AY								
	AZ				Additi	onal References s	sheet(s) attached		
Examiner		JGOOdro	رسو		Date Considered 9/05				
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